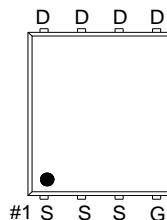
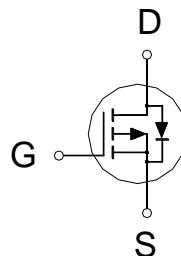


NIKO-SEM**P-Channel Logic Level Enhancement Mode
Field Effect Transistor****P3506EK**
PDFN 5x6P
Halogen-Free & Lead-Free**PRODUCT SUMMARY**

$V_{(BR)DSS}$	$R_{DS(on)}$	I_D
-60V	35mΩ	-27A

**Features**

- Pb-Free, Halogen Free and RoHS compliant.
- Low $R_{DS(on)}$ to Minimize Conduction Losses.
- Ohmic Region Good $R_{DS(on)}$ Ratio.
- Optimized Gate Charge to Minimize Switching Losses.



G. GATE
D. DRAIN
S. SOURCE

100% UIS Tested
100% Rg Tested

Applications

- Protection Circuits Applications.
- Logic/Load Switch Circuits Applications.

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNITS
Drain-Source Voltage	V_{DS}	-60	V
Gate-Source Voltage	V_{GS}	± 25	V
Continuous Drain Current ⁴	I_D	-27	A
		-17	
		-6.7	
		-5.4	
Pulsed Drain Current ¹	I_{DM}	-71	
Avalanche Current	I_{AS}	-29	
Avalanche Energy	E_{AS}	42	mJ
Power Dissipation ³	P_D	48	W
		19	
		3	
		2	
Operating Junction & Storage Temperature Range	T_j, T_{stg}	-55 to 150	°C

NIKO-SEM**P-Channel Logic Level Enhancement Mode
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Halogen-Free & Lead-Free****THERMAL RESISTANCE RATINGS**

THERMAL RESISTANCE		SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$t \leq 10s$	$R_{\theta JA}$		41	°C / W
Junction-to-Ambient ²	Steady-State	$R_{\theta JA}$		77	
Junction-to-Case	Steady-State	$R_{\theta JC}$		2.6	

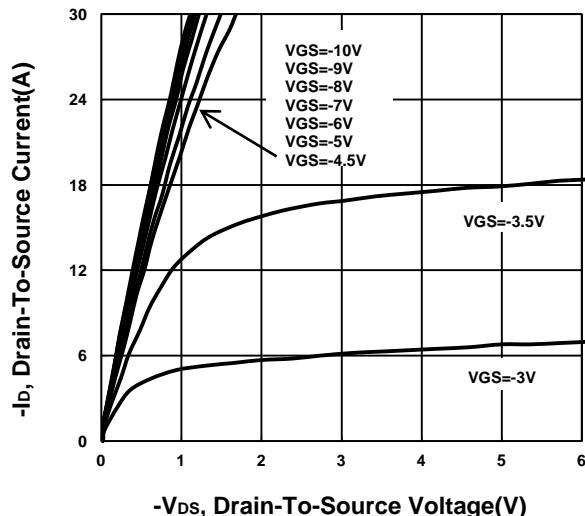
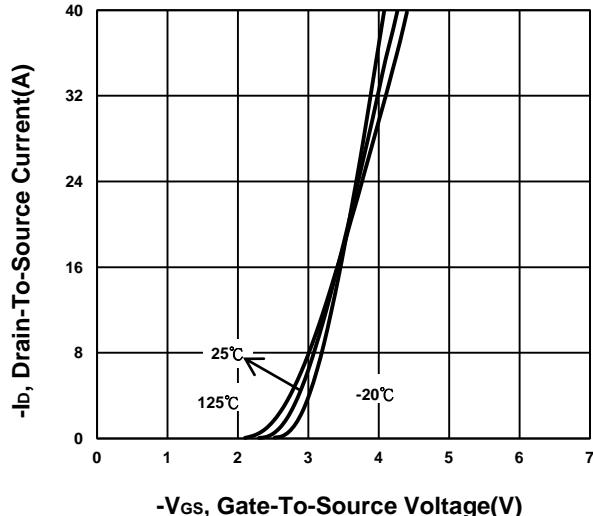
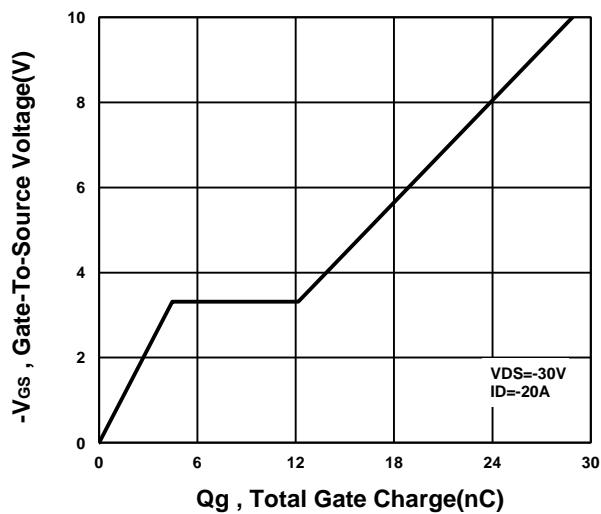
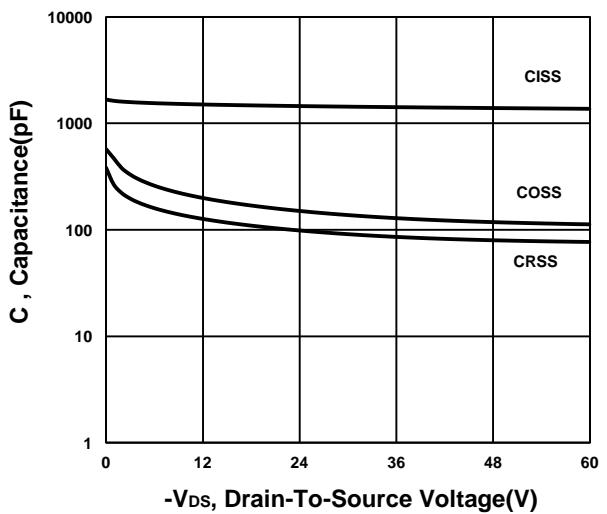
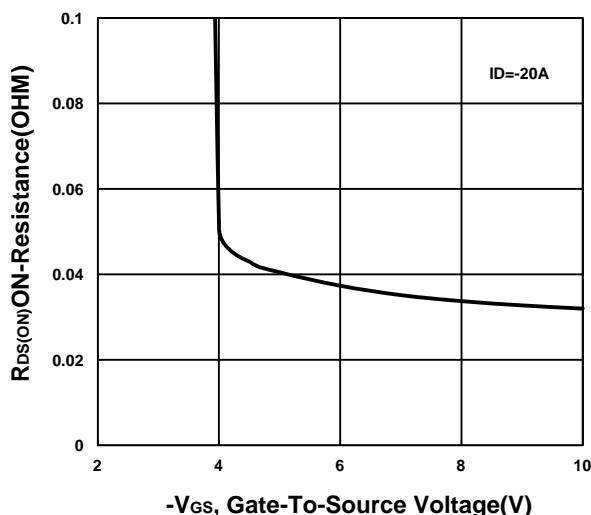
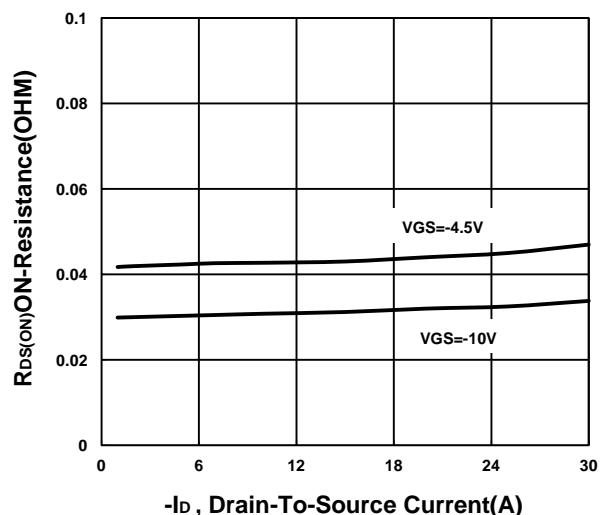
¹Pulse width limited by maximum junction temperature.²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ C$. The value in any given application depends on the user's specific board design.³The Power dissipation is based on $R_{\theta JA} t \leq 10s$ value.⁴The maximum current rating is package limited.**ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ C$, Unless Otherwise Noted)**

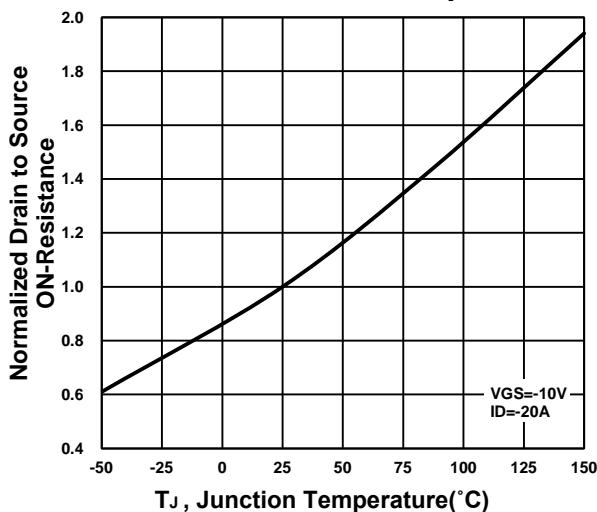
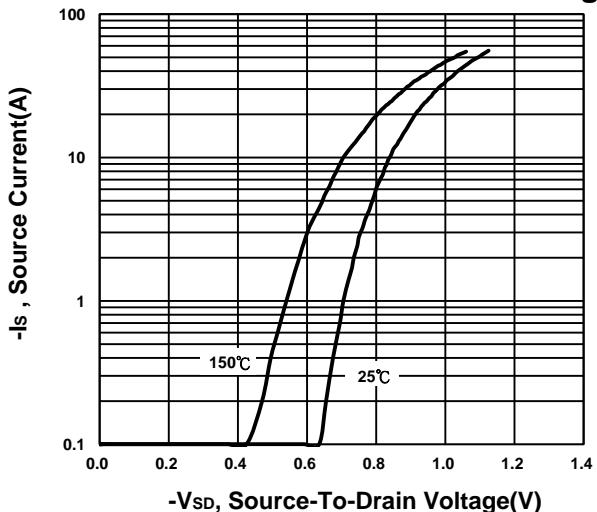
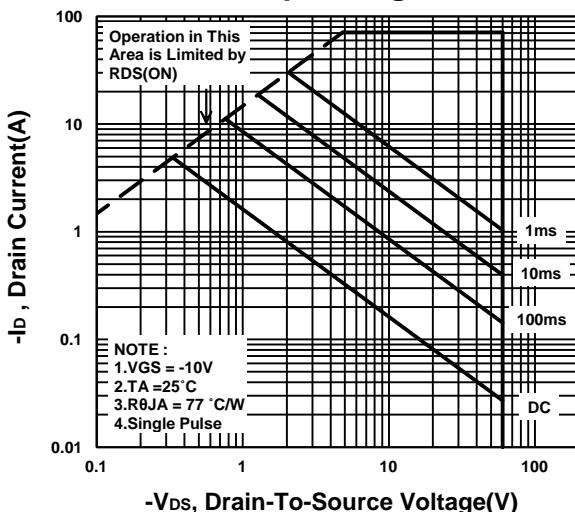
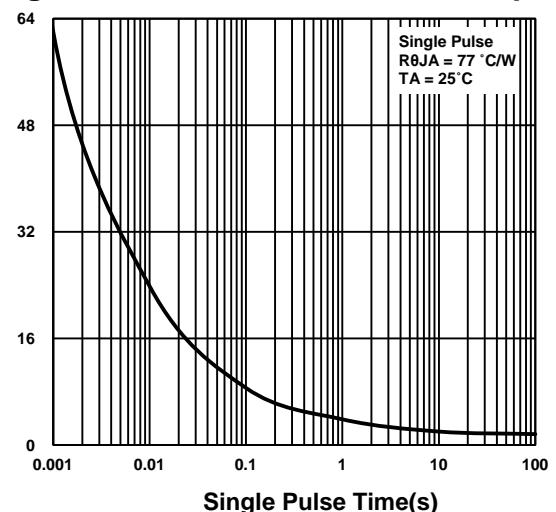
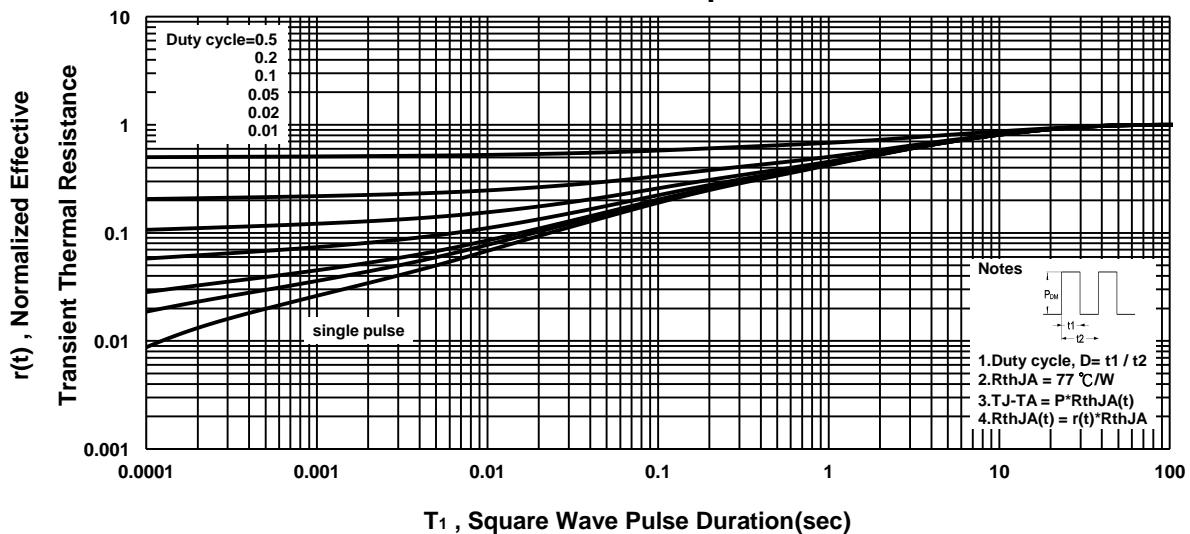
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-60			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-1.3	-1.8	-2.3	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 25V$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -60V, V_{GS} = 0V$			-1	
		$V_{DS} = -60V, V_{GS} = 0V, T_J = 55^\circ C$			-10	uA
Drain-Source On-State Resistance ¹	$R_{DS(ON)}$	$V_{GS} = -10V, I_D = -20A$		32	35	$m\Omega$
		$V_{GS} = -4.5V, I_D = -15A$		43	55	
Forward Transconductance ¹	g_f	$V_{DS} = -5V, I_D = -20A$		28		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = -30V, f = 1MHz$		1440		pF
Output Capacitance	C_{oss}			138		
Reverse Transfer Capacitance	C_{rss}			92		
Gate Resistance	R_g	$V_{GS} = 0V, V_{DS} = 0V, f = 1MHz$		3.6		Ω
Total Gate Charge ²	Q_g	$V_{DS} = -30V, V_{GS} = -10V, I_D = -20A$		29		nC
Gate-Source Charge ²	Q_{gs}			4.5		
Gate-Drain Charge ²	Q_{gd}			7.7		
Turn-On Delay Time ²	$t_{d(on)}$	$V_{DS} = -30V, I_D \approx -20A, V_{GS} = -10V, R_{GS} = 6\Omega$		9.7		nS
Rise Time ²	t_r			60		
Turn-Off Delay Time ²	$t_{d(off)}$			41		
Fall Time ²	t_f			100		

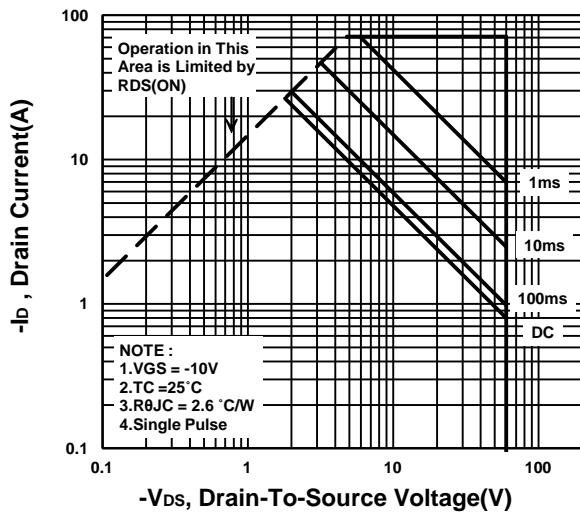
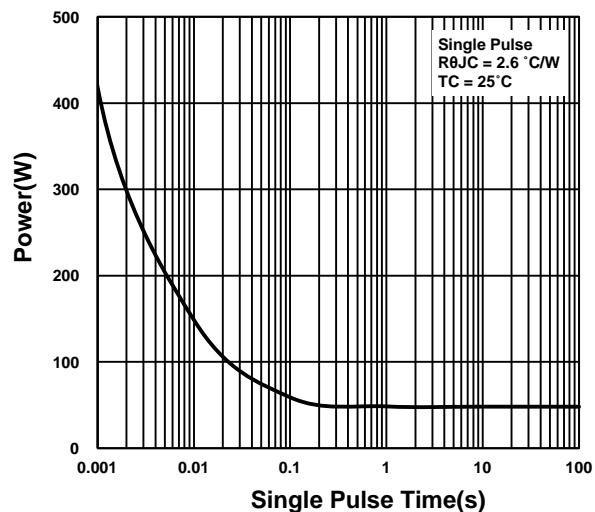
NIKO-SEM**P-Channel Logic Level Enhancement Mode
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PDFN 5x6P
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SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_J = 25^\circ\text{C}$)						
Continuous Current ³	I_S				-21	A
Forward Voltage ¹	V_{SD}	$I_F = -20\text{A}, V_{GS} = 0\text{V}$			-1.3	V
Reverse Recovery Time	t_{rr}	$I_F = -20\text{A}, dI_F/dt = 100 \text{ A / } \mu\text{s}$		12		nS
Reverse Recovery Charge	Q_{rr}			6.4		nC

¹Pulse test : Pulse Width $\leq 300 \mu\text{sec}$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.³The maximum current rating is package limited.

NIKO-SEM**P-Channel Logic Level Enhancement Mode
Field Effect Transistor****P3506EK
PDFN 5x6P
Halogen-Free & Lead-Free****Output Characteristics****Transfer Characteristics****Gate charge Characteristics****Capacitance Characteristic****On-Resistance VS Gate-To-Source Voltage****On-Resistance VS Drain Current**

NIKO-SEM**P-Channel Logic Level Enhancement Mode
Field Effect Transistor****P3506EK
PDFN 5x6P
Halogen-Free & Lead-Free****On-Resistance VS Temperature****Source-Drain Diode Forward Voltage****Safe Operating Area****Single Pulse Maximum Power Dissipation****Transient Thermal Response Curve**

Safe Operating Area**Single Pulse Maximum Power Dissipation****Transient Thermal Response Curve**